

Notice of References Cited	Application/Control No. 10/717,097	Applicant(s)/Patent Under Reexamination ADAPATHYA ET AL.	
	Examiner Tom V. Sheng	Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,044,614 B2	05-2006	Levy et al.	362/84
*	B	US-2004/0212988	10-2004	Fuwausa, Michelle Jillian	362/103
*	C	US-2005/0063199	03-2005	Levy et al.	362/565
*	D	US-6,069,441	05-2000	Lengyel et al.	313/489
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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